

United States Patent and Trademark Office		DEWIPAT File No. 10.092.10.US	
Information Disclosure Statement			
Application No.	10/668,877	Attorney Docket	SP02-211
Filed (yyyy-mm-dd)	2003-09-23	Customer No.	22928
Applicant	Brahim DAHMANI	Confirmation No.	3614
Examiner	Laura M. Schillinger	Art Unit	2813
Title	A Silicon Thin Film Transistor, A Method of Manufacture and a Display Screen		

Applicant submits¹:

☒ References listed on the attached form PTO 1449*.

☐ Copies of references are enclosed (U.S. patents/applications omitted if filing date is after June 30, 2003).

☐ A copy of a communication from a foreign patent office in a counterpart application is enclosed.

☐ English language version of foreign search report indicating degree of relevance is enclosed.

☐ Under 35 U.S.C §120, this application relies on the earlier filing date of application serial number ___, filed on ___.

The following references were submitted to and/or cited by the Office in the prior application and, therefore, are not provided in this application.

02/22/2005 HTECKLU1 00000000 503202 10668877

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This statement is being filed:

☐ with the application.

☐ within three months of the filing date of the application.

☐ before the receipt of a first Office Action on the merits.

☐ after a first Office Action on the merits, but before receipt of a final Office Action or a Notice of Allowance.

☐ I, the undersigned, hereby certify that each item of information contained in this statement was cited in a communication from a foreign patent office in a counterpart foreign application, the communication being dated ___, which is not more than three months prior to filing of this statement.

☒ after a first Office Action on the merits, but before receipt of a final Office Action or a Notice of Allowance.

☒ Late submission fee \$ **180.00** under 37 CFR 1.17(p) is enclosed.

☐ after a final Office Action or a Notice of Allowance, but before payment of the issue fee. I, the undersigned, hereby certify that each item of information in this statement was cited in a communication from a foreign patent office in a counterpart foreign application, the communication being dated ___, which is not more than three months prior to filing this statement. Applicant hereby petitions under CFR 1.97(d) for this statement to be considered.

☐ Submission fee \$ ___ under 37 CFR 1.17(p) is enclosed.

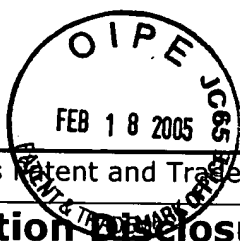
☒ Please apply any additional charges or credits to Deposit Account No. **50-3202**.

SIGNATURE OF Applicant, Attorney, or Agent

Name	Adenike A. Adebiyi	Registration No.	42,254
Signature	<i>Adenike Adebiyi</i>	Telephone	281-477-3450
Date	2/15/2005	Facsimile	281-477-3455

☒ *Total of 1 form PTO-1449 are submitted.

¹ This submission does not represent that a search has been made or that no better art exists and does not constitute an admission that each or all of the enclosed documents constitute "prior art." If it should be determined that any of the submitted documents do not constitute "prior art" under United States law, Applicant reserves the right to present to the office the relevant facts and law regarding the appropriate status of such documents.



		United States Patent and Trademark Office		DEWIPAT File No. 10.092.10.US	
Form PTO-1449 (Modified)		Information Disclosure Citation			Sheet 1 of 1
Application No.	10/668,877	Attorney Docket	SP02-211		
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U.S. PATENT DOCUMENTS				
Examiner Initials*	Cite No.	Document Number Number-Kind Code	Publication Date yyyy-mm-dd	Applicant/Patentee
	B1	5108843	1992-04-28	Ohtaka
	B2	5733641	1998-03-31	Fork

FOREIGN PATENT DOCUMENTS					
Examiner Initials*	Cite No.	Document Number Number-Kind Code	Publication Date yyyy-mm-dd	Applicant/Patentee	T

NON-PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T

EXAMINER: _____ DATE CONSIDERED: _____

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.